

February 19, 2008

Hantat Technology Ltd.  
3/F., C Building, Fuxinlin Industrial Park, Hangcheng Industrial Zone, Xixiang Town  
Baoan District, Shenzhen 518126 China

Dear Gary Ye:

Enclosed you will find your file copy of a Part 15 report (FCC ID: V3N8218).

For your reference, TCB will normally take another 15-20 days for reviewing the report.  
Approval will then be granted when no query is sorted.

Please contact me if you have any questions regarding the enclosed material.

Sincerely,



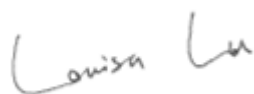
Shawn Xing  
Assistant Manager

Enclosure

## Hantat Technology Ltd.

Application  
For  
Certification  
**(FCC ID: V3N8218)**

Computer Peripheral



GZ08010953-1  
Louisa Lu  
February 19, 2008

- The test results reported in this test report shall refer only to the sample actually tested and shall not refer or be deemed to refer to bulk from which such a sample may be said to have been obtained.
- This report shall not be reproduced except in full without prior authorization from Intertek Testing Services Shenzhen Ltd. Guangzhou Branch
- For Terms And Conditions of the services, it can be provided upon request.
- The evaluation data of the report will be kept for 3 years from the date of issuance.

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# INTERTEK TESTING SERVICES

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## LIST OF EXHIBITS

*INTRODUCTION*

<i>EXHIBIT 1:</i>	General Description
<i>EXHIBIT 2:</i>	System Test Configuration
<i>EXHIBIT 3:</i>	Emission Results
<i>EXHIBIT 4:</i>	Equipment Photographs
<i>EXHIBIT 5:</i>	Product Labeling
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<i>EXHIBIT 7:</i>	Instruction Manual
<i>EXHIBIT 8:</i>	Miscellaneous Information

# INTERTEK TESTING SERVICES

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## MEASUREMENT / TECHNICAL REPORT

Hantat Technology Ltd. – MODEL: soft-PVC

FCC ID: V3N8218

February 19, 2008

This report concerns (check one):      Original Grant  Class II Change

Equipment Type: Class B Computing Device Peripheral (example: computer, printer, modem, etc.)

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Deferred grant requested per 47 CFR 0.457(d)(1)(ii)?      Yes       No

If yes, defer until: \_\_\_\_\_  
date

Company Name agrees to notify the Commission by: \_\_\_\_\_  
date

of the intended date of announcement of the product so that the grant can be issued on that date.

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Transition Rules Request per 15.37?      Yes       No

If no, assumed Part 15, Subpart C for intentional radiator – the new 47 CFR [09-20-07 Edition] provision.

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Report prepared by:

Shawn Xing  
Intertek Testing Services Shenzhen Ltd.  
Guangzhou Branch  
1~8th floor, Block E2, 11 Cai Pin Road,  
Sciencecity, Guangzhou Economic  
Development Zone, Guangzhou, P. R.China.  
Phone: (8620) 8213 9688  
Fax: (8620) 3205 7538

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# INTERTEK TESTING SERVICES

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## INTERTEK TESTING SERVICES

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### List of attached file

Exhibit Type	File Description	Filename
Test Report	Test Report	report.pdf
Test Setup Photo	Radiated Emission	radiated photos.pdf
Test Setup Photo	Conducted Emission	conducted photos.pdf
External Photo	External Photo	external photos.pdf
Internal Photo	Internal Photo	internal photos.pdf
Block Diagram	Block Diagram	block.pdf
ID Label / Location	Label Artwork and Location	label.pdf
User Manual	User Manual	manual.pdf
Cover Letter	Letter of Agency	agency.pdf

# **INTERTEK TESTING SERVICES**

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## **EXHIBIT 1**

### **GENERAL DESCRIPTION**

## INTERTEK TESTING SERVICES

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### 1.0 **General Description**

#### 1.1 Product Description

The Equipment Under Test (EUT) is a Flash Drive with 1GB memory size, model: soft-PVC. The main function of the EUT is to store data and to download the stored data to a PC. The device is powered from PC USB port.

#### 1.2 Related Submittal(s) Grants

This is an application for certification of a computer peripheral.



## INTERTEK TESTING SERVICES

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### 1.3 Test Methodology

Both AC mains line-conducted and radiated emission measurements were performed according to the procedures in ANSI C63.4 (2003). Radiated emission measurement was performed in semi-anechoic chamber and conducted emission measurement was performed in shield room. For radiated emission measurement, preliminary scans were performed in the semi-anechoic chamber only to determine the worst case modes. All radiated tests were performed at an antenna to EUT distance of 3 meters, unless stated otherwise in the "**Justification Section**" of this Application.

### 1.4 Test Facility

The Semi-Anechoic chamber and shield room used to collect the radiated data and conducted data is **SHENZHEN ACADEMY OF METROLOGY AND QUALITY INSPECTION** and located at Bldg. of Metrology & Quality Inspection, Longzhu Road, Shenzhen, Guangdong, China. This test facility and site measurement data have been fully placed on file with the FCC.

**INTERTEK TESTING SERVICES**

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**EXHIBIT 2**  
**SYSTEM TEST CONFIGURATION**

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## INTERTEK TESTING SERVICES

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### 2.0 System Test Configuration

#### 2.1 Justification

The system was configured for testing in a typical fashion (as a customer would normally use it), and in the confines as outlined in ANSI C63.4 (2003).

The EUT was powered from PC USB port

For maximizing emissions, the EUT was rotated through 360°, the antenna height was varied from 1 meter to 4 meters above the ground plane, and the antenna polarization was changed. The step by step procedure for maximizing emissions led to the data reported in Exhibit 3.0.

The rear of unit shall be flushed with the rear of the table.

The equipment under test (EUT) was configured for testing in a typical fashion (as a customer would normally use it). The EUT was placed on turntable, which enabled the engineer to maximize emissions through its placement in the three orthogonal axes.

The frequency range from 30MHz to 1GHz was searched for spurious emissions from the device. Only those emissions reported were detected. All other emissions were at least 20 dB below the applicable limits.

#### 2.2 EUT Exercising Software

There was no special software to exercise the device.

#### 2.3 Special Accessories

There are no special accessories necessary for compliance of this product.

#### 2.4 Equipment Modification

Any modifications installed previous to testing by Hantat Technology Ltd. will be incorporated in each production model sold / leased in the United States.

No modifications were installed by Intertek Testing Services.

## INTERTEK TESTING SERVICES

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### 2.5 Measurement Uncertainty

When determining the test conclusion, the Measurement Uncertainty of test has been considered.

### 2.6 Support Equipment List and Description

This product was tested in the following configuration:

Refer List:

Description	Manufacturer	Model No.	Serial No.
Test PC`	Compaq	P9111A#AB2	CN31104346
LCD Monitor	Compaq	P4825	CN3087A026
Keyboard	Compaq	KB-0133	CT:B55930DGAN N3NU
Mouse	Compaq	M-S69	CT:F466BOMMSNS05J2
Printer	Canon	BJC-265SP	EVX81604
Modem	TP-Link	TM-EC5658V	03402406009
DSLAM	Harbour	Hammer 3300	---
Adaptor for LCD	Liteon	PA-1400-02	3101571101LN
Adaptor for Printer	Canon	AD-300	---
Adaptor for Modem	---	EI-41-AD901	---

All the items listed under section 2.0 of this report are

*Confirmed by:*

*Shawn Xing*  
*Assistant Manager*  
*Intertek Testing Services Shenzhen Ltd.*  
*Guangzhou Branch*  
*Agent for Hantat Technology Ltd.*



\_\_\_\_\_  
Signature

\_\_\_\_\_  
February 19, 2008 Date

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**EXHIBIT 3**  
**EMISSION RESULTS**

## INTERTEK TESTING SERVICES

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### 3.0 Emission Results

Data is included worst case configuration (the configuration which resulted in the highest emission levels). A sample calculation, configuration photographs and data tables of the emissions are included.

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### 3.1 Field Strength Calculation

The field strength is calculated by adding the reading on the Spectrum Analyzer to the factors associated with preamplifiers (if any), antennas, cables, pulse desensitization and average factors (when specified limit is in average and measurements are made with peak detectors). A sample calculation is included below.

$$FS = RA + AF + CF - AG + PD + AV$$

where FS = Field Strength in dB $\mu$ V/m

RA = Receiver Amplitude (including preamplifier) in dB $\mu$ V

CF = Cable Attenuation Factor in dB

AF = Antenna Factor in dB

AG = Amplifier Gain in dB

PD = Pulse Desensitization in dB

AV = Average Factor in -dB

In the radiated emission table which follows, the reading shown on the data table may reflect the preamplifier gain. An example of the calculations, where the reading does not reflect the preamplifier gain, follows:

$$FS = RA + AF + CF - AG + PD + AV$$

## INTERTEK TESTING SERVICES

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### 3.1 Field Strength Calculation (cont'd)

#### Example

Assume a receiver reading of 62.0dB $\mu$ V is obtained. The antenna factor of 7.4dB and cable factor of 1.6dB is added. The amplifier gain of 29dB is subtracted. The pulse desensitization factor of the spectrum analyzer was 0dB, and the resultant average factor was -10dB. The net field strength for comparison to the appropriate emission limit is 32dB $\mu$ V/m. This value in dB $\mu$ V/m was converted to its corresponding level in  $\mu$ V/m.

$$RA = 62.0\text{dB}\mu\text{V}$$

$$AF = 7.4\text{dB}$$

$$CF = 1.6\text{dB}$$

$$AG = 29.0\text{dB}$$

$$PD = 0\text{dB}$$

$$AV = -10\text{dB}$$

$$FS = 62 + 7.4 + 1.6 - 29 + 0 + (-10) = 32\text{dB}\mu\text{V/m}$$

$$\text{Level in } \mu\text{V/m} = \text{Common Antilogarithm } [(32\text{dB}\mu\text{V/m})/20] = 39.8\mu\text{V/m}$$



## INTERTEK TESTING SERVICES

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### 3.2 Radiated Emission Configuration Photograph

Worst Case Radiated Emission  
At  
160.240MHz

For electronic filing, the worst case radiated emission configuration photograph is saved with filename: radiated photos.pdf.

## INTERTEK TESTING SERVICES

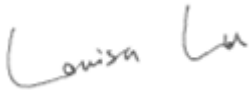
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### 3.3 Radiated Emission Data

The data on the following page lists the significant emission frequencies, the limit and the margin of compliance. Numbers with a minus sign are below the limit.

Judgement: Passed by 4.0dB margin

#### **TEST PERSONNEL:**



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*Signature*

Louisa Lu, Engineer

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*Typed / Printed Name*

February 19, 2008

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*Date*

## INTERTEK TESTING SERVICES

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Company: Hantat Technology Ltd.  
Model: soft-PVC  
Worst Case Operating Mode: Download

Date of Test: February 14, 2008

**Table 1**

**Radiated Emissions**

Polar	Frequency (MHz)	Reading (dBuV)	Pre-Amp (dB)	Antenna factor (dB)	Net at 3m (dBuV/m)	Limit at 3m (dBuV/m)	Margin (dB)
H	62.804	40.4	20.0	7.4	27.8	40.0	-12.2
H	75.018	44.0	20.0	7.1	31.1	40.0	-8.9
H	141.089	41.3	20.0	8.2	29.5	43.5	-14.0
H	160.240	45.7	20.0	9.6	35.3	43.5	-8.2
V	160.240	49.9	20.0	9.6	39.5	43.5	-4.0
V	352.736	37.2	20.0	15.5	32.7	46.0	-13.3

- NOTES: 1. All measurements were made at 3 meters. Harmonic emissions not detected at the 3-meter distances were measured at 0.3-meter and an inverse proportional extrapolation was performed to compare the signal level to the 3-meter limit. No other harmonic emissions than those reported were detected at a test distance of 0.3-meter.
2. Negative value in the margin column shows emission below limit.
3. All emissions are below the QP limit.

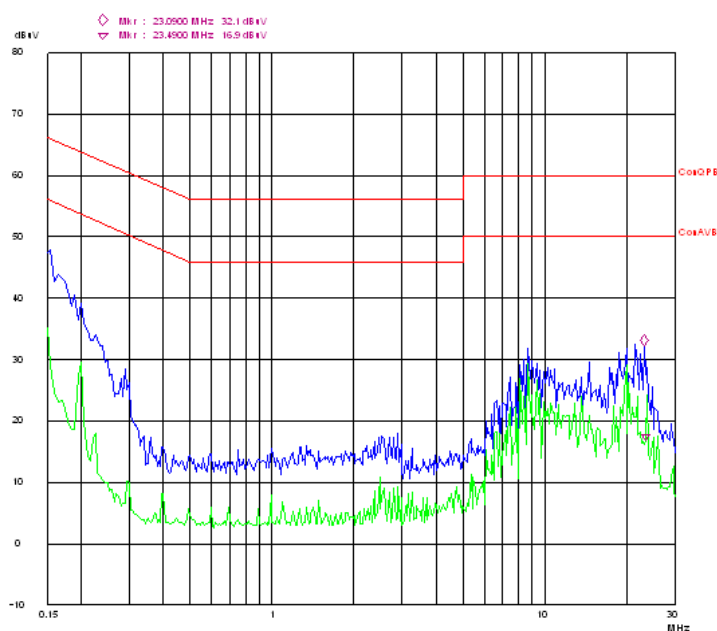
Test Engineer: Louisa Lu

# INTERTEK TESTING SERVICES

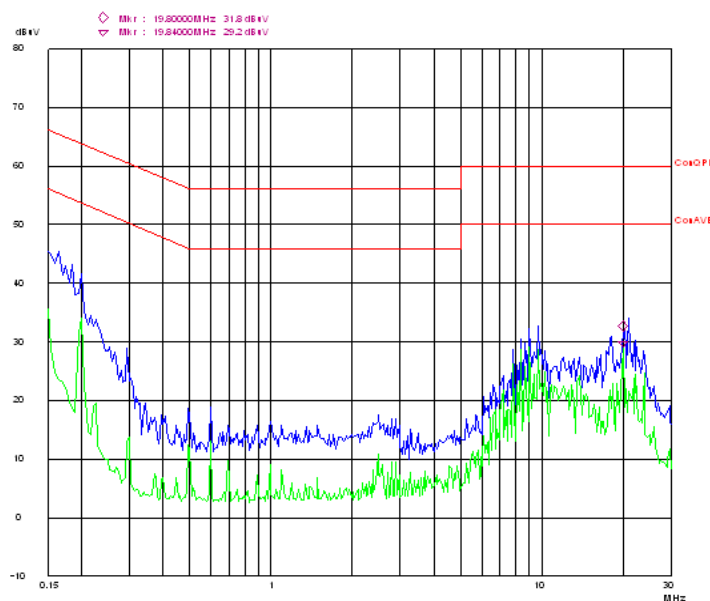
## 3.4 Conducted Emission Configuration Photograph

### Worst Case Line-Conducted Configuration at 0.200 MHz

For electronic filing, the worst case conducted emission configuration photograph is saved with filename: conducted photos.pdf.



(Live Line)



(Neutral Line)

## INTERTEK TESTING SERVICES

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### 3.5 Conducted Emission Data

Judgement: Passed by 19.6 dB margin

#### **TEST PERSONNEL:**

*Louisa Lu*

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*Signature*

Louisa Lu, Engineer  
*Typed/Printed Name*

February 19, 2008  
*Date*

## INTERTEK TESTING SERVICES

Company: Hantat Technology Ltd.  
Model: soft-PVC  
Worst Case Operating Mode: Download

Date of Test: February 18, 2008

**Table 2**  
**Conducted Emissions**

### Live Line Data

Frequency (MHz)	Quasi-Peak		Average	
	Disturbance level dB( $\mu$ V)	Permitted limit dB( $\mu$ V)	Disturbance level dB( $\mu$ V)	Permitted limit dB( $\mu$ V)
0.155	38.2	65.7	28.4	55.7
0.190	30.9	64.0	17.6	54.0
0.200	32.5	63.6	29.6	53.6
7.460	24.6	60.0	22.1	50.0
8.680	28.4	60.0	24.1	50.0
19.850	29.3	60.0	28.6	50.0

### Neutral Line Data

Frequency (MHz)	Quasi-Peak		Average	
	Disturbance level dB( $\mu$ V)	Permitted limit dB( $\mu$ V)	Disturbance level dB( $\mu$ V)	Permitted limit dB( $\mu$ V)
0.150	42.0	66.0	35.9	56.0
0.200	35.6	63.6	34.0	53.6
0.295	18.3	60.3	12.8	50.3
8.950	30.1	60.0	27.6	50.0
9.610	30.5	60.0	27.8	50.0
19.840	29.8	60.0	29.2	50.0

Test Engineer: Louisa Lu

**INTERTEK TESTING SERVICES**

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**EXHIBIT 4**  
**EQUIPMENT PHOTOGRAPHS**

## INTERTEK TESTING SERVICES

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### 4.0 **Equipment Photographs**

For electronic filing, photographs of the tested EUT are saved with filename: external photos.pdf and internal photos.pdf.



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**EXHIBIT 5**  
**PRODUCT LABELLING**

## INTERTEK TESTING SERVICES

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### 5.0 **Product Labelling**

For electronics filing, the FCC ID label artwork and the label location are saved with filename: label.pdf.

**INTERTEK TESTING SERVICES**

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**EXHIBIT 6**  
**TECHNICAL SPECIFICATIONS**

## INTERTEK TESTING SERVICES

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### 6.0 Technical Specifications

For electronic filing, the block diagram of the tested EUT is saved with filename: block.pdf.

**EXHIBIT 7**  
**INSTRUCTION MANUAL**

## INTERTEK TESTING SERVICES

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### 7.0 Instruction Manual

For electronic filing, a preliminary copy of the Instruction Manual is saved with filename: manual.pdf.

This manual will be provided to the end-user with each unit sold / leased in the United States.

**INTERTEK TESTING SERVICES**

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**EXHIBIT 8**

**MISCELLANEOUS INFORMATION**

## INTERTEK TESTING SERVICES

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### 8.0 Miscellaneous Information

This miscellaneous information includes emission measuring procedure.



## **INTERTEK TESTING SERVICES**

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### **8.1 Emissions Test Procedures**

The following is a description of the test procedure used by Intertek Testing Services in the measurements of computer peripheral operating under Part 15, Subpart B rules.

The test set-up and procedures described below are designed to meet the requirements of ANSI C63.4 – 2003.

The computer peripheral equipment under test (EUT) is placed on a wooden turntable which is four feet in diameter and approximately one meter in height above the ground plane. During the radiated emissions test, the turntable is rotated and any cables leaving the EUT are manipulated to find the configuration resulting in maximum emissions. The antenna height and polarization are varied during the testing to search for maximum signal levels. The height of the antenna is varied from one to four meters.

Detector function for radiated emissions is in QP mode from the frequency band 30MHz to 1GHz and RBW setting is 120kHz. Detector function for conducted emissions are in QP & AV mode and IFBW setting is 9kHz from the frequency band 150kHz to 30MHz.

For radiated emission, the frequency range scanned is 30MHz to 1GHz. For line-conducted emissions, the range scanned is 150kHz to 30MHz.

## **INTERTEK TESTING SERVICES**

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### 8.1 Emissions Test Procedures (cont'd)

The EUT is warmed up for 15 minutes prior to the test.

Conducted measurements are made as described in ANSI C63.4 – 2003.